

# Search Notes



Application/Control No.

10/644,182

Examiner

José V. Chen

Applicant(s)/Patent under Reexamination

BUECHLER, JAMES G.

Art Unit

3637

## SEARCHED

Class	Subclass	Date	Examiner
108	180	6/2/05	JLC
	105		
	182		
	187		
	190		
	143		
	153.1		
	155		
	157.18		
	158.12		
312	257.1		
	265.1		
	265.2		
	195		
250	180		
	182.1		
		11/16/05	JLC
		1/3/06	JLC
		4/26/06	JLC
		1/22/06	JLC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
108	180	1/3/06	JLC
	158.12		

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
<del>Front &amp; back.</del>	6/2/05	JLC
<del>CITATIONS FOR</del>		
<del>PROT. ART</del>		
<del>PPACOR</del>	11/16/05	JLC
<del>UPDA COR</del>	1/3/06	JLC
<del>FOR SEARCH</del>		
<del>UPDA COR</del>	4/26/06	JLC